## REASUNES

#### N Channel MOSFET

#### Applications:

- •Adapter & Charger
- •SMPS Standby Power
- •AC-DC Switching Power Supply
- •LED driving power

#### Features:

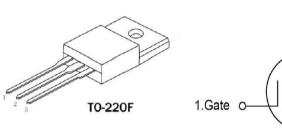
- •Low On Resistance
- •Low Gate Charge
- •Peak Current vs Pulse Width Curve
- •RoHS Compliant

# 🗭 Lead

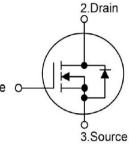
### Lead Free Package and Finish

**RS8N80F** 

ID	RDS(ON)(Typ.)	Vdss
8. 0A	$1.42 \Omega$	800V



Not to Scale



Ordering Information

Part Number	Package	Marking
RS8N80F	T0-220F	RS8N80F

#### Absolute Maximun Ratings Tc=25°C unless otherwise specified

Symbol	Parameter	RS8N80F	Units
VDSS	Drain-to-Source Voltage (Note*1)	800	V
ID	Continuous Drain Current	8.0	
ID@ 100 °C	Continuous Drain Current	5.1	А
IDM	Pulsed Drain Current (Note*2)	32.0	
DD	Power Dissipation	57	W
PD	Derating Factor above 25℃	0.46	₩/°C
VGS	Gate-to-Source Voltage	$\pm 30$	V
EAS	Single Pulse Avalanche Engergy L=30mH IAS=5.5A VDD=135V RG=25Ω TJ=25℃	534	mJ
	Maximum Temperature for Soldering		
TL TPKG	Leads at 0.063in(1.6mm)from Case for 10 seconds Package Body for 10 seconds	300 260	°C
TJ and TSTG	Operating Junction and Storage Temperature Range	-55 to 150	

\*Drain Current Limited by Maximum Junction Temperature

Caution:Stresses greater than those listed in the "Absolute Maximum Ratings" Table may cause permanent damage to the device.

#### Thermal Resistance

Symbol	Parameter	RS8N80F	Units	Test Conditions
Rejc	Junction-to-Case	2.19	°C/W	Drain lead soldered to water cooled heatsink,PD adjusted for a peak junction temperature of +150°C.
Rөja	Junction-to-Ambient	120		1 cubic foot chamber, free air.

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BVDSS	Drain-to-source Breakdown Voltage	800			V	V <sub>GS</sub> =0V, I <sub>D</sub> =250µA
IDSS	Drain-to-Source Leakage Current		-	1.0	μĄ	VDS=800V, VGS=0V
T	Gate-to-Source Forward Leakage	1		100		VGS=+30V VDS=0V
IGSS	Gate-to-Source Reverse Leakage			-100	nA	V <sub>GS</sub> =-30V V <sub>DS</sub> =0V

**OFF Characteristics** TJ=25°C unless otherwise specified

#### ON Characteristics TJ=25°C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
RDS (on)	Static Drain-to-Source On-Resistance		1.42	1.6	Ω	VGS=10V, ID=4. 0A
Vgs (TH)	Gate Threshold Voltage	2.0		4.0	V	VGS=VDS, ID=250µA

Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
td(ON)	Turn-on Delay Time		30.33	-		VDS=400V ID=8.0A RG=25Ω (Note:3,4)
trise	Rise Time		67.00	-		
td(OFF)	Turn-OFF Delay Time		58.00		nS	
tfall	Fall Time		38.33			

Dynamic Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Ciss	Input Capacitance		1083		pF	$V_{GS}=0V$ $V_{DS}=25V$ f=1.0MHz
Coss	Output Capacitance		103			
Crss	Reverse Transfer Capacitance		5.8			
$Q_{ m g}$	Total Gate Charge		24.62			VDS=640V ID=8.0A VGS=10V (Note:3,4)
$Q_{gs}$	Gate-to-Source Charge		7.26		nC	
Qgd	Gate-to-Drain("Miller") Charge		8.97			



#### Source-Drain Diode Characteristics

Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
Is	Continuous Source Current			8.0	А	Integral pn-diode
ISM	Maximum Pulsed Current			32.0	А	in MOSFET
Vsd	Diode Forward Voltage		-	1.4	V	Is=8. 0A, Vgs=0V
trr	Reverse Recovery Time		310.00		nS	V <sub>GS</sub> =0V
$Q_{ m rr}$	Reverse Recovery Charge		0.53		μC	Is=8.0A, di/dt=100A/µs

#### Notes:

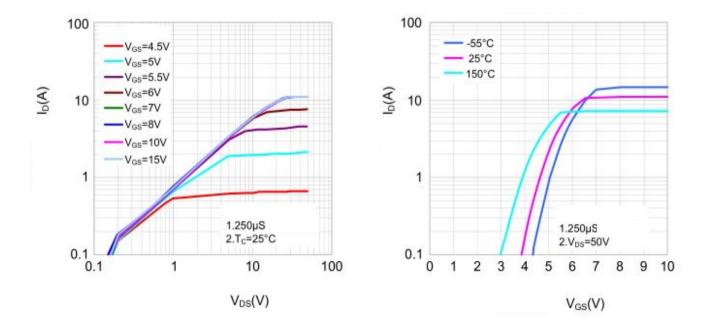
\*1.TJ=±25℃ to +150℃.

- \*2. Repetitive rating; pulse width limited by maximum junction temperature.
- \*3. Pulse width  $\leq$  300 $\mu$ s; duty cycle  $\leq$  2%.
- \*4. Basically not affected by temperature.

#### Typical Feature curve

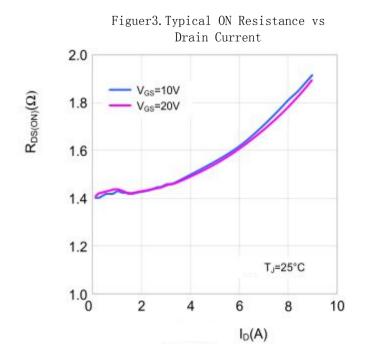
Figure1. Typical Output Characteristics

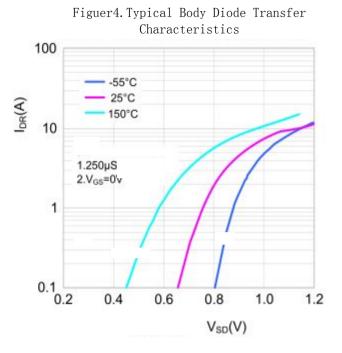
Figure2. Typical Transfer Characteristics

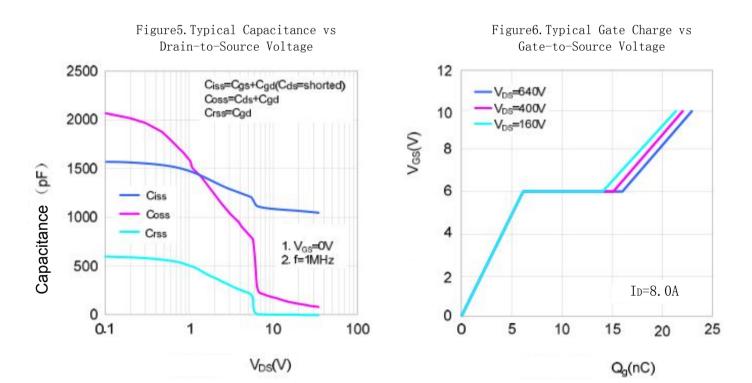


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## RS8N80F







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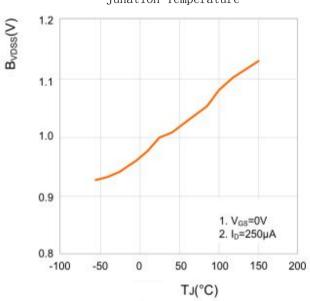


Figure7. Typical Breakdown Voltage vs

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Junation Temperature R<sub>DS(ON)</sub>(Ω 3.0 2.5 2.0 1.5 1.0

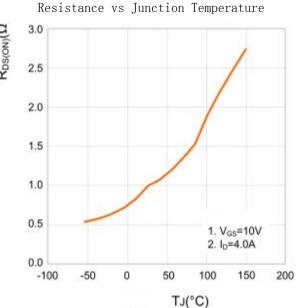
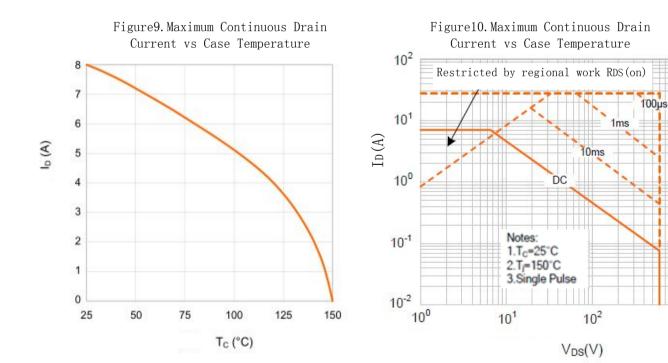


Figure8. Figure10. Typical Drain-to-Source ON



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 $10^{3}$ 



### Test Circuits and Waveforms

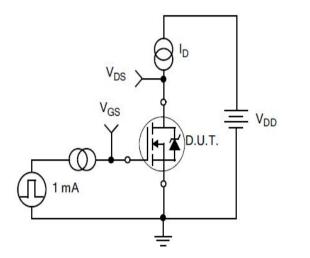


Figure11. Gate Charge Test Circuit



VDS

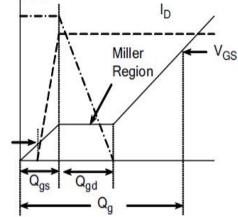


Figure12. Gate Charge Waveform

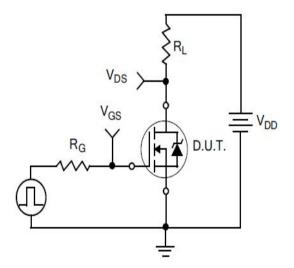
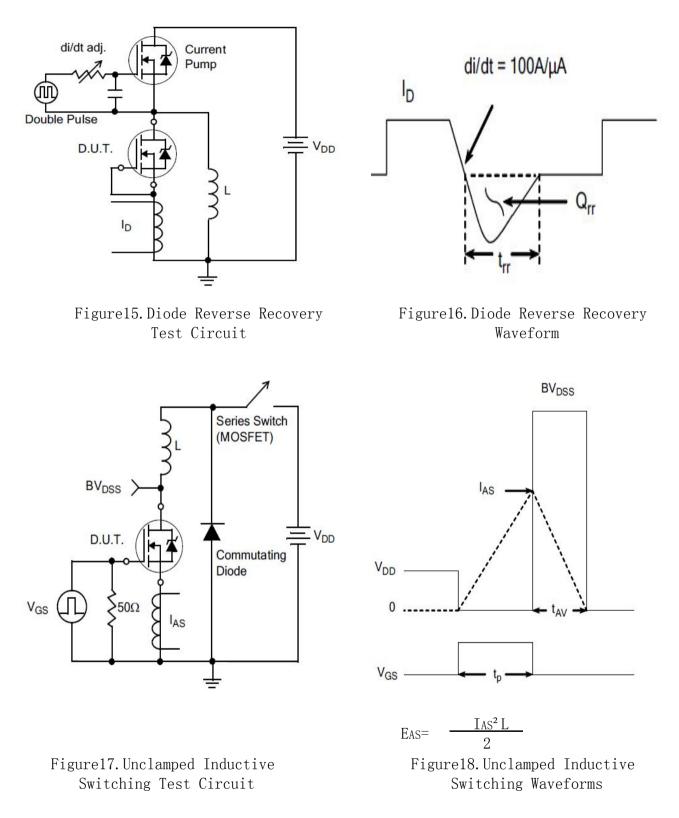


Figure13. Resistive Switching Test Circuit

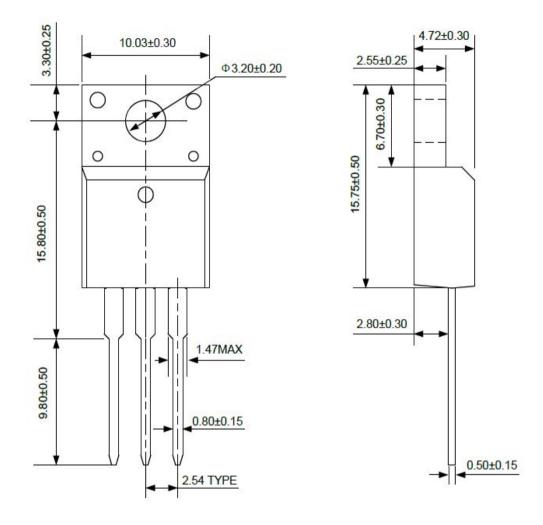
Figure14. Resistive Switching Waveforms



Test Circuits and Waveforms



### Package outline drawing



T0-220F



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